# TOSHIBA

# TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC TC74AC125P, TC74AC125F, TC74AC125FN, TC74AC125FT TC74AC126P, TC74AC126F, TC74AC126FN TC74AC125P/F/FN/FT QUAD BUS BUFFER (Note) The JEDEC SOP (FN) is not

TC74AC126P/F/FN QUAD BUS BUFFER

(Note) The JEDEC SOP (FN) is not available in Japan.

The TC74AC125/126 are advanced high speed CMOS QUAD BUS BUFFERs fabricated with silicon gate and double - layer metal wiring C<sup>2</sup>MOS technology.

They achieve the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

The TC74AC125 requires the 3-state control input  $\overline{G}$  to be set high to place the output into the high impedance state, whereas the TC74AC126 requires the control input to be set low to place the output into high impedance.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

## FEATURES:

- High Speed------t<sub>pd</sub> = 4.0ns(typ.) at  $V_{CC}$  = 5V
- High Noise Immunity  $V_{NIH} = V_{NIL} = 28\% V_{CC}$  (Min.)

• Symmetrical Output Impedance…  $|I_{OH}| = I_{OL} = 24$ mA(Min.)

Capability of driving  $50\Omega$  transmission lines.

- Balanced Propagation Delays……  $t_{pLH} \simeq t_{pHL}$
- Wide Operating Voltage Range  $\sim V_{CC}$  (opr) = 2V ~ 5.5V
- $\bullet$  Pin and Function Compatible with 74F125/126

## IEC LOGIC SYMBOL





## TRUTH TABLE

TC74A0	2125
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INP	UTS	OUTPUTS
G	А	Y
Н	Х	Z
L	L	L
L	Н	н

X: Don't Care Z: High Impedance

#### TC74AC126

INP	UTS	OUTPUTS			
G	А	Y			
L	Х	Z			
Н	L	L			
Н	Н	Н			

X: Don't Care Z: High Impedance

#### **ABSOLUTE MAXIMUM RATINGS**

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	V <sub>cc</sub>	-0.5~7.0	V
DC Input Voltage	VIN	-0.5~V <sub>CC</sub> +0.5	V
DC Output Voltage	V <sub>OUT</sub>	$-0.5 \sim V_{CC} + 0.5$	V
Input Diode Current	Ι <sub>ικ</sub>	± 20	mA
Output Diode Current	Ι <sub>οκ</sub>	± 50	mA
DC Output Current	I <sub>OUT</sub>	± 50	mA
DC V <sub>CC</sub> /Ground Current	I <sub>cc</sub>	± 100	mA
Power Dissipation	P <sub>D</sub>	500 (DIP)* /180 (SOP/TSSOP)	mW
Storage Temperature	T <sub>stg</sub>	-65~150	°C

\*500mW in the range of Ta = -40°C~65°C. From Ta = 65°C to 85°C a derating factor of -10mW/°C should be applied up to 300mW.

#### **RECOMMENDED OPERATING CONDITIONS**

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	V <sub>cc</sub>	2.0~5.5	V
Input Voltage	VIN	0~V <sub>cc</sub>	V
Output Voltage	V <sub>OUT</sub>	0~V <sub>cc</sub>	V
Operating Temperature	T <sub>opr</sub>	-40~85	°C
Input Rise and Fall Time	dt/dV	0~ 100 (Vcc = 3.3 ± 0.3V) 0~ 20 (Vcc = 5±0.5V)	ns / V

DC ELECTRICAL CHARACTERISTICS										
PARAMETER SYMBOL TEST CONDITION				V <sub>cc</sub>	Г	Ta = 25°C			Ta = −40~85°C	
		(V)	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT		
High - Level Input Voltage	VIH		2.0 3.0 5.5	1.50 2.10 3.85			1.50 2.10 3.85	=	v	
Low - Level Input Voltage	VIL						0.50 0.90 1.65		0.50 0.90 1.65	v
High - Level Output Voltage	V <sub>OH</sub>	V <sub>IH</sub> or V <sub>IL</sub>	$I_{OH} = -50 \mu A$	2.0 3.0 4.5	1.9 2.9 4.4	2.0 3.0 4.5		1.9 2.9 4.4		v
			$I_{OH} = -4mA$ $I_{OH} = -24mA$ $I_{OH} = -75mA*$	3.0 4.5 5.5	2.58 3.94 			2.48 3.80 3.85		
Low - Level Output Voltage			I <sub>OL</sub> = 50μA	2.0 3.0 4.5		0.0 0.0 0.0	0.1 0.1 0.1		0.1 0.1 0.1	V
	V <sub>OL</sub>	V <sub>OL</sub> V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 12mA I <sub>OL</sub> = 24mA I <sub>OL</sub> = 75mA*	3.0 4.5 5.5			0.36 0.36 —		0.44 0.44 1.65	V
3 - State Output Off - State Current	I <sub>oz</sub>	$V_{1N} = V_{1H} \text{ or } V_{1L}$ $V_{OUT} = V_{CC} \text{ or } GND$		5.5	_	_	±0.5	_	± 5.0	_
Input Leakage Current	I <sub>IN</sub>	$V_{IN} = V_{CC}$ or GND		5.5	—	_	±0.1	—	± 1.0	μΑ
<b>Quiescent Supply Current</b>	I <sub>CC</sub>	$V_{IN} = V_{CC} \text{ or } GN$	5.5	—	—	8.0	—	80.0		

### **DC ELECTRICAL CHARACTERISTICS**

\* : This spec indicates the capability of driving  $50 \Omega$  transmission lines.

One output should be tested at a time for a 10ms maximum duration.

PARAMETER	SYMBOL	TEST CONDITION		-	Ta = 25°C	2	Ta = - 4	UNIT	
FARAIVIETER	STIVIBOL		V <sub>cc</sub> (V)	MIN.	TYP.	MAX.	MIN.	MAX.	
Propagation Delay Time	t <sub>pLH</sub> t <sub>pHL</sub>		3.3 ± 0.3 5.0 ± 0.5		6.4 4.7	10.5 7.0	1.0 1.0	12.0 8.0	
Output Enable Time	t <sub>pZL</sub> t <sub>pZH</sub>		3.3 ± 0.3 5.0 ± 0.5		7.1 5.0	12.3 7.9	1.0 1.0	14.0 9.0	ns
Output Disable Time	t <sub>pLZ</sub> t <sub>pHZ</sub>		3.3±0.3 5.0±0.5		5.1 4.6	8.8 6.6	1.0 1.0	10.0 7.5	
Input Capacitance	C <sub>IN</sub>			_	5	10	—	10	
Output Capacitance	C <sub>OUT</sub>			—	10	—	—	—	pF
Power Dissipation Capacitance	C <sub>PD</sub> (1)			—	24	—	—	—	

## AC ELECTRICAL CHARACTERISTICS ( $C_L$ = 50pF, $R_L$ = 500 $\Omega,$ Input $\,t_r$ = $t_f$ = 3ns )

Note (1)  $C_{PD}$  is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC (opr.)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC} / 4 (per Gate)$$

## DIP 14PIN PACKAGE DIMENSIONS (DIP14-P-300-2.54)

Unit in mm



## SOP 14PIN (200mil BODY) PACKAGE DIMENSIONS (SOP14-P-300-1.27)







070

0.45~0.75

0.25

+0.025

0.17

0.24<sup>+0.08</sup> -0.07 0.13 (M)

.0±0.05

0.1±0.05

2MAX

0.65

5.25MAX

 $5.0 \pm 0.1$ 

- 🗌 0.1

0.55TYF

Weight: 0.06g (Typ.)

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